Search Notes

Application/Control No.	Applicant(s Reexaminat
09/964.537	SHIN. YEO

Examiner

Soon D. Hyun

Applicant(s)/Patent under Reexamination SHIN, YEONG JONG Art Unit

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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
370/331,335,336,342,347; 455/436- 444,448; text search only-see search history printout	1/9/2007	НҮ	
Discussed with Chau Nguyen (SPE of AU 2616)	1/22/2007	НҮ	
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